# Dual-Channel, Digital Isolators, Enhanced System-Level ESD Reliability 

## ADuM3200/ADuM3201

## FEATURES

Enhanced system-level ESD performance per IEC 61000-4-x Narrow body, 8-lead SOIC, Pb-free package
Low power operation
5 V operation
1.6 mA per channel maximum @ 0 Mbps to $\mathbf{2}$ Mbps
3.7 mA per channel maximum @ 10 Mbps
7.5 mA per channel maximum @ 25 Mbps

3 V operation
1.4 mA per channel maximum @ $\mathbf{0} \mathbf{~ M b p s}$ to $\mathbf{2} \mathbf{~ M b p s}$
2.4 mA per channel maximum @ 10 Mbps
4.6 mA per channel maximum @ 25 Mbps

Bidirectional communication
$3 \mathrm{~V} / 5 \mathrm{~V}$ level translation
High temperature operation: $\mathbf{1 0 5}^{\circ} \mathrm{C}$
High data rate: dc to $\mathbf{2 5}$ Mbps (NRZ)
Precise timing characteristics
3 ns maximum pulse-width distortion
3 ns maximum channel-to-channel matching
High common-mode transient immunity: > $\mathbf{2 5} \mathbf{~ k V} / \mu \mathrm{s}$
Safety and regulatory approvals
UL recognition: $\mathbf{2 5 0 0}$ V rms for 1 minute per UL 1577
CSA Component Acceptance Notice \#5A
VDE Certificate of Conformity
DIN EN 60747-5-2 (VDE 0884 Part 2): 2003-01
DIN EN 60950 (VDE 0805): 2001-12; DIN EN 60950: 2000
$\mathrm{V}_{\text {IORM }}=560 \mathrm{~V}$ peak

## APPLICATIONS

Size-critical multichannel isolation SPI ${ }^{\oplus}$ interface/data converter isolation
RS-232/RS-422/RS-485 transceiver isolation
Digital field bus isolation

## GENERAL DESCRIPTION

The ADuM320x ${ }^{1}$ are dual-channel, digital isolators based on Analog Devices' iCoupler ${ }^{\ominus}$ technology. Combining high speed CMOS and monolithic transformer technology, these isolation components provide outstanding performance characteristics superior to alternatives such as optocoupler devices.

By avoiding the use of LEDs and photodiodes, $i$ Coupler devices remove the design difficulties commonly associated with optocouplers. The typical optocoupler concerns regarding uncertain current transfer ratios, nonlinear transfer functions, and temperature and lifetime effects are eliminated with the simple iCoupler digital interfaces and stable performance characteristics. The need for external drivers and other discrete components is eliminated with these $i$ Coupler products. Furthermore, $i$ Coupler devices consume one-tenth to one-sixth the power of optocouplers at comparable signal data rates.

The ADuM320x isolators provide two independent isolation channels in a variety of channel configurations and data rates (see the Ordering Guide). Both parts operate with the supply voltage on either side ranging from 2.7 V to 5.5 V , providing compatibility with lower voltage systems as well as enabling a voltage translation functionality across the isolation barrier. The ADuM320x isolators have a patented refresh feature that ensures dc correctness in the absence of input logic transitions and during power-up/power-down conditions.

In comparison to the ADuM120x isolators, the ADuM320x isolators contain various circuit and layout changes to provide increased capability relative to system-level IEC 61000-4-x testing (ESD, burst, surge). The precise capability in these tests for either the ADuM120x or ADuM320x products is strongly determined by the design and layout of the user's board or module. For more information, see Application Note AN-793, ESD/Latch-Up Considerations with iCoupler Isolation Products.

## FUNCTIONAL BLOCK DIAGRAMS



Figure 1. ADuM3200 Functional Block Diagram


Figure 2. ADuM3201 Functional Block Diagram

Rev. 0
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## ADuM3200/ADuM3201

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## REVISION HISTORY

7/06-Revision 0: Initial Version

## ADuM3200/ADuM3201

## SPECIFICATIONS

## ELECTRICAL CHARACTERISTICS—5 V OPERATION

All voltages are relative to their respective ground. $4.5 \mathrm{~V} \leq \mathrm{V}_{\mathrm{DD} 1} \leq 5.5 \mathrm{~V}, 4.5 \mathrm{~V} \leq \mathrm{V}_{\mathrm{DD} 2} \leq 5.5 \mathrm{~V}$. All minimum/maximum specifications apply over the entire recommended operating range, unless otherwise noted. All typical specifications are at $T_{A}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{DD1}}=\mathrm{V}_{\mathrm{DD} 2}=5 \mathrm{~V}$.
Table 1.

| Parameter | Symbol | Min | Typ | Max | Unit | Test Conditions |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DC SPECIFICATIONS |  |  |  |  |  |  |
| Input Supply Current, per Channel, Quiescent | IDDI (0) |  | 0.4 | 0.8 | mA |  |
| Output Supply Current, per Channel, Quiescent | IDDo (0) |  | 0.5 | 0.6 | mA |  |
| ADuM3200, Total Supply Current, Two Channels ${ }^{1}$ DC to 2 Mbps |  |  |  |  |  |  |
| $V_{\text {DD } 1}$ Supply Current | IDD1 (0) |  | 1.3 | 1.7 | mA | DC to 1 MHz logic signal freq. |
| $\mathrm{V}_{\mathrm{DD} 2}$ Supply Current | $\mathrm{IDD2}$ () |  | 1.0 | 1.6 | mA | DC to 1 MHz logic signal freq. |
| 10 Mbps (BR and CR Grades Only) |  |  |  |  |  |  |
| V ${ }_{\text {DD } 1}$ Supply Current | $\operatorname{ldD1}(10)$ |  | 3.5 | 4.6 | mA | 5 MHz logic signal freq. |
| $\mathrm{V}_{\mathrm{DD} 2}$ Supply Current | $\mathrm{IDD2}^{(10)}$ |  | 1.7 | 2.8 | mA | 5 MHz logic signal freq. |
| 25 Mbps (CR Grade Only) |  |  |  |  |  |  |
| V DD1 Supply Current | $1 \mathrm{ld1} 125$ |  | 7.7 | 10.0 | mA | 12.5 MHz logic signal freq. |
| $\mathrm{V}_{\mathrm{DD} 2}$ Supply Current | IDD2 (25) |  | 3.1 | 3.9 | mA | 12.5 MHz logic signal freq. |
| ADuM3201,Total Supply Current, Two Channels ${ }^{1}$ DC to 2 Mbps |  |  |  |  |  |  |
| $\mathrm{V}_{\mathrm{DD} 1}$ Supply Current | IDD1 (0) |  | 1.1 | 1.5 | mA | DC to 1 MHz logic signal freq. |
| $\mathrm{V}_{\text {DD2 }}$ Supply Current | $\mathrm{IDD2}$ () |  | 1.3 | 1.8 | mA | DC to 1 MHz logic signal freq. |
| 10 Mbps (BR and CR Grades Only) |  |  |  |  |  |  |
| V ${ }_{\text {DDI }}$ Supply Current | $\operatorname{ldD1}(10)$ |  | 2.6 | 3.4 | mA | 5 MHz logic signal freq. |
| $\mathrm{V}_{\mathrm{DD} 2}$ Supply Current | $\mathrm{IDD2}^{(10)}$ |  | 3.1 | 4.0 | mA | 5 MHz logic signal freq. |
| 25 Mbps (CR Grade Only) |  |  |  |  |  |  |
| $V_{\text {DD } 1}$ Supply Current | IDD1 (25) |  | 5.3 | 6.8 | mA | 12.5 MHz logic signal freq. |
| $\mathrm{V}_{\text {DD } 2}$ Supply Current | IDD2 (25) |  | 6.4 | 8.3 | mA | 12.5 MHz logic signal freq. |
| For All Models |  |  |  |  |  |  |
| Input Currents | $l_{\text {IA }}, l_{\text {l }}$ | -10 | +0.01 | +10 | $\mu \mathrm{A}$ | $0 \leq \mathrm{V}_{\mathrm{IA}}, \mathrm{V}_{\mathrm{IB}} \leq \mathrm{V}_{\mathrm{DD} 1}$ or $\mathrm{V}_{\mathrm{DD} 2}$ |
| Logic High Input Threshold | $\mathrm{V}_{\mathrm{H}}$ | $\begin{aligned} & 0.7 \mathrm{~V}_{\mathrm{DD} 1}, \\ & \mathrm{~V}_{\mathrm{D} 2} \end{aligned}$ |  |  | V |  |
| Logic Low Input Threshold | VIL |  |  | $0.3 \mathrm{~V}_{\mathrm{DD} 1}$ $V_{D D 2}$ | v |  |
| Logic High Output Voltages | Voat | $V_{D D 1}$, <br> $V_{D D 2}-0.1$ | 5.0 |  | v | $\mathrm{l}_{\text {ox }}=-20 \mu \mathrm{~A}, \mathrm{~V}_{1 \mathrm{x}}=\mathrm{V}_{\text {lxH }}$ |
|  | $\mathrm{V}_{\text {OBH }}$ | $V_{D D 1}$, $\mathrm{V}_{\mathrm{DD} 2}-0.5$ | 4.8 |  | v | $\mathrm{l}_{\mathrm{ox}}=-4 \mathrm{~mA}, \mathrm{~V}_{1 \mathrm{x}}=\mathrm{V}_{\text {IxH }}$ |
| Logic Low Output Voltages | $V_{\text {oal }}$ |  | 0.0 | 0.1 | v | $\mathrm{l}_{\text {Ox }}=20 \mu \mathrm{~A}, \mathrm{~V}_{1 \mathrm{x}}=\mathrm{V}_{\text {Ix }}$ |
|  | $V_{\text {obl }}$ |  | 0.04 | 0.1 | V | $\mathrm{l}_{\text {ox }}=400 \mu \mathrm{~A}, \mathrm{~V}_{\text {lx }}=\mathrm{V}_{\text {lxL }}$ |
|  |  |  | 0.2 | 0.4 | V | $\mathrm{l}_{\mathrm{ox}}=4 \mathrm{~mA}, \mathrm{~V}_{1 \mathrm{x}}=\mathrm{V}_{\text {Ix }}$ |
| SWITCHING SPECIFICATIONS |  |  |  |  |  |  |
| ADuM320xAR |  |  |  |  |  |  |
| Minimum Pulse Width ${ }^{2}$ | PW |  |  | 1000 | ns | $\mathrm{C}_{L}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Maximum Data Rate ${ }^{3}$ |  | 1 |  |  | Mbps | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Propagation Delay ${ }^{4}$ | $\mathrm{t}_{\text {PHL, }}$ t PLH | 20 |  | 150 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Pulse-Width Distortion, \|t trLH $\left.^{-t_{\text {PrLL }}}\right\|^{4}$ | PWD |  |  | 40 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Propagation Delay Skew ${ }^{5}$ | $t_{\text {Psk }}$ |  |  | 100 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Channel-to-Channel Matching ${ }^{6}$ | teskco/od |  |  | 50 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Output Rise/Fall Time (10\% to 90\%) | $\mathrm{t}_{\mathrm{R}} / \mathrm{t}_{\mathrm{F}}$ |  | 10 |  | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |

## ADuM3200/ADuM3201

| Parameter | Symbol | Min | Typ | Max | Unit | Test Conditions |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ADuM320xBR |  |  |  |  |  |  |
| Minimum Pulse Width ${ }^{2}$ | PW |  |  | 100 | ns | $C_{L}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Maximum Data Rate ${ }^{3}$ |  | 10 |  |  | Mbps | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Propagation Delay ${ }^{4}$ | $\mathrm{t}_{\text {PHL, }} \mathrm{t}_{\text {PLH }}$ | 20 |  | 50 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Pulse-Width Distortion, $\left\|\mathrm{t}_{\text {PLH }}-\mathrm{t}_{\text {PHL }}\right\|^{4}$ | PWD |  |  | 3 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Change vs. Temperature |  |  | 5 |  | $\mathrm{ps} /{ }^{\circ} \mathrm{C}$ | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Propagation Delay Skew ${ }^{5}$ | tpsk |  |  | 15 | ns | $C_{L}=15 \mathrm{pF}$, CMOS signal levels |
| Channel-to-Channel Matching, Codirectional Channels ${ }^{6}$ | $\mathrm{t}_{\text {PKKCD }}$ |  |  | 3 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Channel-to-Channel Matching, Opposing Directional Channels ${ }^{6}$ | tPSKOD |  |  | 15 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Output Rise/Fall Time (10\% to 90\%) | $\mathrm{t}_{\mathrm{R}} / \mathrm{t}_{\mathrm{F}}$ |  | 2.5 |  | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| ADuM320xCR |  |  |  |  |  |  |
| Minimum Pulse Width ${ }^{2}$ | PW |  | 20 | 40 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Maximum Data Rate ${ }^{3}$ |  | 25 | 50 |  | Mbps | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Propagation Delay ${ }^{4}$ | $\mathrm{t}_{\text {PHL, }} \mathrm{t}_{\text {PLL }}$ | 20 |  | 45 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Pulse-Width Distortion, $\left\|t_{\text {PLH }}-t_{\text {PHL }}\right\|^{4}$ | PWD |  |  | 3 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Change vs. Temperature |  |  | 5 |  | $\mathrm{ps} /{ }^{\circ} \mathrm{C}$ | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Propagation Delay Skew ${ }^{5}$ | $t_{\text {PSK }}$ |  |  | 15 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Channel-to-Channel Matching, Codirectional Channels ${ }^{6}$ | tPSKCD |  |  | 3 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Channel-to-Channel Matching, Opposing Directional Channels ${ }^{6}$ | $\mathrm{t}_{\text {PSKOD }}$ |  |  | 15 | ns | $C_{L}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Output Rise/Fall Time (10\% to 90\%) | $\mathrm{t}_{\mathrm{R}} / \mathrm{t}_{\mathrm{F}}$ |  | 2.5 |  | ns | $C_{L}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| For All Models |  |  |  |  |  |  |
| Common-Mode Transient Immunity at Logic High Output ${ }^{7}$ | \|CM ${ }_{\text {H }}$ | 25 | 35 |  | kV/ $\mu \mathrm{s}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{IX}}=\mathrm{V}_{\mathrm{DD} 1}, \mathrm{~V}_{\mathrm{DD} 2}, \mathrm{~V}_{\mathrm{CM}}=1000 \mathrm{~V}, \\ & \text { transient magnitude }=800 \mathrm{~V} \end{aligned}$ |
| Common-Mode Transient Immunity at Logic Low Output ${ }^{7}$ | \|CM ${ }_{\text {L }}$ | 25 | 35 |  | $\mathrm{kV} / \mathrm{\mu s}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{Ix}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{CM}}=1000 \mathrm{~V}, \\ & \text { transient magnitude }=800 \mathrm{~V} \end{aligned}$ |
| Refresh Rate | $\mathrm{fr}_{\mathrm{r}}$ |  | 1.2 |  | Mbps |  |
| Input Dynamic Supply Current, per Channel ${ }^{8}$ | $\mathrm{I}_{\text {DII ( } \mathrm{D})}$ |  | 0.19 |  | mA/Mbps |  |
| Output Dynamic Supply Current, per Channel ${ }^{8}$ | IDDO (D) |  | 0.05 |  | mA/Mbps |  |

${ }^{1}$ The supply current values for both channels are combined when running at identical data rates. Output supply current values are specified with no output load present. The supply current associated with an individual channel operating at a given data rate can be calculated as described in the Power Consumption section. See Figure 6 through Figure 8 for information on per-channel supply current as a function of data rate for unloaded and loaded conditions. See Figure 9 through Figure 11 for total $I_{D D 1}$ and $I_{D D 2}$ supply currents as a function of data rate for ADuM3200 and ADuM3201 channel configurations.
${ }^{2}$ The minimum pulse width is the shortest pulse width at which the specified pulse-width distortion is guaranteed.
${ }^{3}$ The maximum data rate is the fastest data rate at which the specified pulse-width distortion is guaranteed.
${ }^{4}$ tpHL $^{\text {p }}$ propagation delay is measured from the $50 \%$ level of the falling edge of the $V_{1 \times}$ signal to the $50 \%$ level of the falling edge of the $V_{\text {Ox }}$ signal. tpL propagation delay is measured from the $50 \%$ level of the rising edge of the $\mathrm{V}_{1 \times}$ signal to the $50 \%$ level of the rising edge of the $\mathrm{V}_{\text {ox }}$ signal.
${ }^{5} t_{\text {PSK }}$ is the magnitude of the worst-case difference in $t_{P H L}$ and/or $t_{P L H}$ that is measured between units at the same operating temperature, supply voltages, and output load within the recommended operating conditions.
${ }^{6}$ Codirectional channel-to-channel matching is the absolute value of the difference in propagation delays between any two channels with inputs on the same side of the isolation barrier. Opposing directional channel-to-channel matching is the absolute value of the difference in propagation delays between any two channels with inputs on opposing sides of the isolation barrier.
${ }^{7} \mathrm{CM}_{H}$ is the maximum common-mode voltage slew rate that can be sustained while maintaining $\mathrm{V}_{\mathrm{O}}>0.8 \mathrm{~V}_{\mathrm{DD2}}$. $\mathrm{CM}_{\mathrm{L}}$ is the maximum common-mode voltage slew rate that can be sustained while maintaining $\mathrm{V}_{0}<0.8 \mathrm{~V}$. The common-mode voltage slew rates apply to both rising and falling common-mode voltage edges. The transient magnitude is the range over which the common mode is slewed.
${ }^{8}$ Dynamic supply current is the incremental amount of supply current required for a 1 Mbps increase in the signal data rate. See Figure 6 through Figure 8 for information on per-channel supply current for unloaded and loaded conditions. See the Power Consumption section for guidance on calculating per-channel supply current for a given data rate.

## ADuM3200/ADuM3201

## ELECTRICAL CHARACTERISTICS—3 V OPERATION

All voltages are relative to their respective ground. $2.7 \mathrm{~V} \leq \mathrm{V}_{\mathrm{DD} 1} \leq 3.6 \mathrm{~V}, 2.7 \mathrm{~V} \leq \mathrm{V}_{\mathrm{DD} 2} \leq 3.6 \mathrm{~V}$. All minimum/maximum specifications apply over the entire recommended operating range, unless otherwise noted. All typical specifications are at $T_{A}=25^{\circ} \mathrm{C}$,
$\mathrm{V}_{\mathrm{DD} 1}=\mathrm{V}_{\mathrm{DD} 2}=3.0 \mathrm{~V}$.
Table 2.

| Parameter | Symbol | Min | Typ | Max | Unit | Test Conditions |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DC SPECIFICATIONS |  |  |  |  |  |  |
| Input Supply Current, per Channel, Quiescent | $\mathrm{ldDI}(0)$ |  | 0.3 | 0.5 | mA |  |
| Output Supply Current, per Channel, Quiescent | IDDo (0) |  | 0.3 | 0.5 | mA |  |
| ADuM3200, Total Supply Current, Two Channels ${ }^{1}$ DC to 2 Mbps |  |  |  |  |  |  |
|  |  |  |  |  |  |  |
| $\mathrm{V}_{\mathrm{DD} 1}$ Supply Current | $1 \mathrm{ldi}($ () |  | 0.8 | 1.3 | mA | DC to 1 MHz logic signal freq. |
| $\mathrm{V}_{\mathrm{DD} 2}$ Supply Current | $\mathrm{IDD2}^{(0)}$ |  | 0.7 | 1.0 | mA | DC to 1 MHz logic signal freq. |
| 10 Mbps (BR and CR Grades Only) |  |  |  |  |  |  |
| $\mathrm{V}_{\text {DD } 1}$ Supply Current | IDD1 (10) |  | 2.0 | 3.2 | mA | 5 MHz logic signal freq. |
| $\mathrm{V}_{\text {DD } 2}$ Supply Current | $\mathrm{ldD2}$ (10) |  | 1.1 | 1.7 | mA | 5 MHz logic signal freq. |
| 25 Mbps (CR Grade Only) |  |  |  |  |  |  |
| $\mathrm{V}_{\mathrm{DD} 1}$ Supply Current | IDD1 (25) |  | 4.3 | 6.4 | mA | 12.5 MHz logic signal freq. |
| $\mathrm{V}_{\mathrm{DD} 2}$ Supply Current | IDD2 (25) |  | 1.8 | 2.4 | mA | 12.5 MHz logic signal freq. |
| ADuM3201, Total Supply Current, Two Channels ${ }^{1}$ DC to 2 Mbps |  |  |  |  |  |  |
| $\mathrm{V}_{\mathrm{DD} 1}$ Supply Current | $\mathrm{IDD1}$ (0) |  | 0.7 | 1.3 | mA | DC to 1 MHz logic signal freq. |
| $\mathrm{V}_{\mathrm{DD} 2}$ Supply Current | $\mathrm{ldD2}$ (0) |  | 0.8 | 1.6 | mA | DC to 1 MHz logic signal freq. |
| 10 Mbps (BR and CR Grades Only) |  |  |  |  |  |  |
| $V_{\text {DD } 1}$ Supply Current | IDD1 (10) |  | 1.5 | 2.1 | mA | 5 MHz logic signal freq. |
| $\mathrm{V}_{\mathrm{DD} 2}$ Supply Current | $\mathrm{ldD2}$ (10) |  | 1.9 | 2.4 | mA | 5 MHz logic signal freq. |
| 25 Mbps (CR Grade Only) |  |  |  |  |  |  |
| V ${ }_{\text {DD } 1}$ Supply Current | lodi (25) |  | 3.0 | 4.2 | mA | 12.5 MHz logic signal freq. |
| $\mathrm{V}_{\mathrm{DD} 2}$ Supply Current | IDD2 (25) |  | 3.6 | 5.1 | mA | 12.5 MHz logic signal freq. |
| For All Models |  |  |  |  |  |  |
| Input Currents |  | -10 | +0.01 | +10 | $\mu \mathrm{A}$ | $0 \leq \mathrm{V}_{1 /}, \mathrm{V}_{1 B}, \leq \mathrm{V}_{\mathrm{DD} 1}$ or $\mathrm{V}_{\text {DD } 2}$ |
| Logic High Input Threshold | $\mathrm{V}_{\mathrm{IH}}$ | $0.7 \mathrm{~V}_{\mathrm{DD} 1},$ $\mathrm{V}_{\mathrm{DD} 2}$ |  |  | V |  |
| Logic Low Input Threshold | $\mathrm{V}_{\text {IL }}$ |  |  | $\begin{aligned} & 0.3 \mathrm{~V}_{\mathrm{DD} 1}, \\ & \mathrm{~V}_{\mathrm{DD} 2} \end{aligned}$ | V |  |
| Logic High Output Voltages | Vоah | $V_{D D 1}$, <br> $V_{D D 2}-0.1$ | 3.0 |  | V | $\mathrm{l}_{\text {ox }}=-20 \mu \mathrm{~A}, \mathrm{~V}_{1 \mathrm{x}}=\mathrm{V}_{\text {lxH }}$ |
|  | Vовн | $V_{D D 1}$, <br> $V_{D D 2}-0.5$ | 2.8 |  | V | $\mathrm{loxx}=-4 \mathrm{~mA}, \mathrm{~V}_{1 \mathrm{x}}=\mathrm{V}_{\text {lxH }}$ |
| Logic Low Output Voltages | $V_{\text {OAL }}$ |  | 0.0 | 0.1 | V | $\mathrm{l}_{\text {Ox }}=20 \mu \mathrm{~A}, \mathrm{~V}_{\mathrm{l}}=\mathrm{V}_{\text {IxL }}$ |
|  | Vobl |  | 0.04 | 0.1 | V | $\mathrm{l}_{\text {ox }}=400 \mu \mathrm{~A}, \mathrm{~V}_{\text {lx }}=\mathrm{V}_{\text {IxL }}$ |
|  |  |  | 0.2 | 0.4 | V | $\mathrm{l}_{\mathrm{ox}}=4 \mathrm{~mA}, \mathrm{~V}_{\mathrm{lx}}=\mathrm{V}_{\text {IxL }}$ |
| SWITCHING SPECIFICATIONS |  |  |  |  |  |  |
| ADuM320xAR |  |  |  |  |  |  |
| Minimum Pulse Width ${ }^{2}$ | PW |  |  | 1000 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Maximum Data Rate ${ }^{3}$ |  | 1 |  |  | Mbps | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Propagation Delay ${ }^{4}$ | $\mathrm{t}_{\text {PHL, }} \mathrm{t}_{\text {PLL }}$ | 20 |  | 150 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Pulse-Width Distortion, $\mid$ tpLH - trpl ${ }^{4}$ | PWD |  |  | 40 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Propagation Delay Skew ${ }^{5}$ | tpsk |  |  | 100 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Channel-to-Channel Matching ${ }^{6}$ | tpskco/od |  |  | 50 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Output Rise/Fall Time (10\% to 90\%) | $\mathrm{t}_{\mathrm{R}} / \mathrm{t}_{\mathrm{F}}$ |  | 10 |  | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |

## ADuM3200/ADuM3201

| Parameter | Symbol | Min | Typ | Max | Unit | Test Conditions |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ADuM320xBR |  |  |  |  |  |  |
| Minimum Pulse Width ${ }^{2}$ | PW |  |  | 100 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Maximum Data Rate ${ }^{3}$ |  | 10 |  |  | Mbps | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Propagation Delay ${ }^{4}$ | $\mathrm{t}_{\text {PHL, }} \mathrm{t}_{\text {PLH }}$ | 20 |  | 60 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Pulse-Width Distortion, $\left\|t_{\text {PLL }}-t_{\text {PHLL }}\right\|^{4}$ | PWD |  |  | 3 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Change vs. Temperature |  |  | 5 |  | $\mathrm{ps} /{ }^{\circ} \mathrm{C}$ | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Propagation Delay Skew ${ }^{5}$ | tpsk |  |  | 22 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Channel-to-Channel Matching, Codirectional Channels ${ }^{6}$ | $\mathrm{t}_{\text {PKKCD }}$ |  |  | 3 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Channel-to-Channel Matching, Opposing Directional Channels ${ }^{6}$ | tPSKOD |  |  | 22 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Output Rise/Fall Time (10\% to 90\%) | $\mathrm{t}_{\mathrm{R}} / \mathrm{t}_{\mathrm{F}}$ |  | 3.0 |  | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| ADuM320xCR |  |  |  |  |  |  |
| Minimum Pulse Width ${ }^{2}$ | PW |  | 20 | 40 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Maximum Data Rate ${ }^{3}$ |  | 25 | 50 |  | Mbps | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Propagation Delay ${ }^{4}$ | tPHL, tPLH | 20 |  | 55 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Pulse-Width Distortion, $\left\|\mathrm{t}_{\text {PLH }}-\mathrm{t}_{\text {PHL }}\right\|^{4}$ | PWD |  |  | 3 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Change vs. Temperature |  |  | 5 |  | $\mathrm{ps} /{ }^{\circ} \mathrm{C}$ | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Propagation Delay Skew ${ }^{5}$ | $t_{\text {PSK }}$ |  |  | 16 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Channel-to-Channel Matching, Codirectional Channels ${ }^{6}$ | tPSKCD |  |  | 3 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Channel-to-Channel Matching, Opposing Directional Channels ${ }^{6}$ | $\mathrm{t}_{\text {PSKOD }}$ |  |  | 16 | ns | $C_{L}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Output Rise/Fall Time (10\% to 90\%) | $\mathrm{t}_{\mathrm{R}} / \mathrm{t}_{\mathrm{F}}$ |  | 3.0 |  | ns | $C_{L}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| For All Models |  |  |  |  |  |  |
| Common Mode Transient Immunity at Logic High Output ${ }^{7}$ | \|CM ${ }^{\text {\| }}$ | 25 | 35 |  | kV/ $\mu \mathrm{s}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{Ix}}=\mathrm{V}_{\mathrm{DD} 1}, \mathrm{~V}_{\mathrm{DD} 2}, \mathrm{~V}_{\mathrm{CM}}=1000 \mathrm{~V}, \\ & \text { transient magnitude }=800 \mathrm{~V} \end{aligned}$ |
| Common Mode Transient Immunity at Logic Low Output ${ }^{7}$ | \| $\mathrm{CM}_{\mathrm{L}}$ \| | 25 | 35 |  | $\mathrm{kV} / \mathrm{\mu s}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{Ix}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{CM}}=1000 \mathrm{~V}, \\ & \text { transient magnitude }=800 \mathrm{~V} \end{aligned}$ |
| Refresh Rate | $\mathrm{fr}_{\mathrm{r}}$ |  | 1.1 |  | Mbps |  |
| Input Dynamic Supply Current, per Channel ${ }^{8}$ | $\mathrm{I}_{\text {DII ( }{ }^{\text {( }} \text { ) }}$ |  | 0.10 |  | mA/Mbps |  |
| Output Dynamic Supply Current, per Channel ${ }^{8}$ | IDDO (D) |  | 0.03 |  | mA/Mbps |  |

${ }^{1}$ The supply current values for both channels are combined when running at identical data rates. Output supply current values are specified with no output load present. The supply current associated with an individual channel operating at a given data rate may be calculated as described in the Power Consumption section. See Figure 6 through Figure 8 for information on per-channel supply current as a function of data rate for unloaded and loaded conditions. See Figure 9 through Figure 11 for total $I_{D D 1}$ and $I_{D D 2}$ supply currents as a function of data rate for ADuM3200 and ADuM3201 channel configurations.
${ }^{2}$ The minimum pulse width is the shortest pulse width at which the specified pulse-width distortion is guaranteed.
${ }^{3}$ The maximum data rate is the fastest data rate at which the specified pulse-width distortion is guaranteed.
${ }^{4}$ tpHL $^{\text {p }}$ propagation delay is measured from the $50 \%$ level of the falling edge of the $V_{1 \times}$ signal to the $50 \%$ level of the falling edge of the $V_{\text {Ox }}$ signal. tpL propagation delay is measured from the $50 \%$ level of the rising edge of the $\mathrm{V}_{1 \times}$ signal to the $50 \%$ level of the rising edge of the $\mathrm{V}_{\text {ox }}$ signal.
${ }^{5} t_{\text {PSK }}$ is the magnitude of the worst-case difference in $t_{P H L}$ and/or $t_{P L H}$ that is measured between units at the same operating temperature, supply voltages, and output load within the recommended operating conditions.
${ }^{6}$ Codirectional channel-to-channel matching is the absolute value of the difference in propagation delays between any two channels with inputs on the same side of the isolation barrier. Opposing directional channel-to-channel matching is the absolute value of the difference in propagation delays between any two channels with inputs on opposing sides of the isolation barrier.
${ }^{7} \mathrm{CM}_{H}$ is the maximum common-mode voltage slew rate that can be sustained while maintaining $\mathrm{V}_{\mathrm{O}}>0.8 \mathrm{~V}_{\mathrm{DD2}}$. $\mathrm{CM}_{\mathrm{L}}$ is the maximum common-mode voltage slew rate that can be sustained while maintaining $\mathrm{V}_{0}<0.8 \mathrm{~V}$. The common-mode voltage slew rates apply to both rising and falling common-mode voltage edges. The transient magnitude is the range over which the common mode is slewed.
${ }^{8}$ Dynamic supply current is the incremental amount of supply current required for a 1 Mbps increase in the signal data rate. See Figure 6 through Figure 8 for information on per-channel supply current for unloaded and loaded conditions. See the Power Consumption section for guidance on calculating per-channel supply current for a given data rate.

## ADuM3200/ADuM3201

## ELECTRICAL CHARACTERISTICS—MIXED 5 V/3 V OR 3 V/5 V OPERATION

All voltages are relative to their respective ground. $5 \mathrm{~V} / 3 \mathrm{~V}$ operation: $4.5 \mathrm{~V} \leq \mathrm{V}_{\mathrm{DD} 1} \leq 5.5 \mathrm{~V}, 2.7 \mathrm{~V} \leq \mathrm{V}_{\mathrm{DD} 2} \leq 3.6 \mathrm{~V} .3 \mathrm{~V} / 5 \mathrm{~V}$ operation: $2.7 \mathrm{~V} \leq \mathrm{V}_{\mathrm{DD} 1} \leq 3.6 \mathrm{~V}, 4.5 \mathrm{~V} \leq \mathrm{V}_{\mathrm{DD} 2} \leq 5.5 \mathrm{~V}$. All minimum/maximum specifications apply over the entire recommended operating range, unless otherwise noted. All typical specifications are at $T_{A}=25^{\circ} \mathrm{C} ; \mathrm{V}_{\mathrm{DD} 1}=3.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DD} 2}=5.0 \mathrm{~V}$; or $\mathrm{V}_{\mathrm{DD} 1}=5.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DD} 2}=3.0 \mathrm{~V}$.

Table 3.

| Parameter | Symbol | Min | Typ | Max | Unit | Test Conditions |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DC SPECIFICATIONS |  |  |  |  |  |  |
| Input Supply Current, per Channel, Quiescent | IDDI (0) |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 0.4 | 0.8 | mA |  |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 0.3 | 0.5 | mA |  |
| Output Supply Current, per Channel, Quiescent | IDDo (0) |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 0.3 | 0.5 | mA |  |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 0.5 | 0.6 | mA |  |
| ADuM3200, Total Supply Current, Two Channels ${ }^{1}$ DC to 2 Mbps |  |  |  |  |  |  |
| $V_{\text {DDI }}$ Supply Current | $\mathrm{IDD1}$ (0) |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 1.3 | 1.7 | mA | DC to 1 MHz logic signal freq. |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 0.8 | 1.3 | mA | DC to 1 MHz logic signal freq. |
| $\mathrm{V}_{\mathrm{DD} 2}$ Supply Current | $\mathrm{IDD2}$ (Q) |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 0.7 | 1.0 | mA | DC to 1 MHz logic signal freq. |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 1.0 | 1.6 | mA | DC to 1 MHz logic signal freq. |
| 10 Mbps (BR and CR Grades Only) |  |  |  |  |  |  |
| $V_{\text {DDI }}$ Supply Current | $\mathrm{IDD1}_{(10)}$ |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 3.5 | 4.6 | mA | 5 MHz logic signal freq. |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 2.0 | 3.2 | mA | 5 MHz logic signal freq. |
| $\mathrm{V}_{\mathrm{DD} 2}$ Supply Current | $\mathrm{IDD2}(10)$ |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 1.1 | 1.7 | mA | 5 MHz logic signal freq. |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 1.7 | 2.8 | mA | 5 MHz logic signal freq. |
| 25 Mbps (CR Grade Only) |  |  |  |  |  |  |
| $V_{\text {DDI }}$ Supply Current | $\mathrm{IDD1}$ (25) |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 7.7 | 10.0 | mA | 12.5 MHz logic signal freq. |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 4.3 | 6.4 | mA | 12.5 MHz logic signal freq. |
| $\mathrm{V}_{\mathrm{DD} 2}$ Supply Current | $\mathrm{IDD2}^{(25)}$ |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 1.8 | 2.4 | mA | 12.5 MHz logic signal freq. |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 3.1 | 3.9 | mA | 12.5 MHz logic signal freq. |
| ADuM3201,Total Supply Current, Two Channels ${ }^{1}$ DC to 2 Mbps |  |  |  |  |  |  |
| $V_{\text {DD } 1}$ Supply Current | $\mathrm{ldD1}$ (0) |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 1.1 | 1.5 | mA | DC to 1 MHz logic signal freq. |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 0.7 | 1.3 | mA | DC to 1 MHz logic signal freq. |
| $\mathrm{V}_{\mathrm{DD} 2}$ Supply Current | $\mathrm{ldD2}$ (Q) |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 0.8 | 1.6 | mA | DC to 1 MHz logic signal freq. |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 1.3 | 1.8 | mA | DC to 1 MHz logic signal freq. |
| 10 Mbps (BR and CR Grades Only) |  |  |  |  |  |  |
| VDD1 Supply Current | $\operatorname{ldD1}(10)$ |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 2.6 | 3.4 | mA | 5 MHz logic signal freq. |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 1.5 | 2.1 | mA | 5 MHz logic signal freq. |
| VDD2 Supply Current | ldD2 (10) |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 1.9 | 2.4 | mA | 5 MHz logic signal freq. |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 3.1 | 4.0 | mA | 5 MHz logic signal freq. |

## ADuM3200/ADuM3201



| Parameter | Symbol | Min | Typ | Max | Unit | Test Conditions |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ADuM320xCR |  |  |  |  |  |  |
| Minimum Pulse Width ${ }^{2}$ | PW |  | 20 | 40 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Maximum Data Rate ${ }^{3}$ |  | 25 | 50 |  | Mbps | $\mathrm{C}_{L}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Propagation Delay ${ }^{4}$ | $\mathrm{t}_{\text {PHL }}, \mathrm{tPLH}$ | 20 |  | 50 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Pulse-Width Distortion, $\left\|\mathrm{t}_{\text {PLL }}-\mathrm{t}_{\text {PHL }}\right\|^{4}$ | PWD |  |  | 3 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Change vs. Temperature |  |  | 5 |  | $\mathrm{ps} /{ }^{\circ} \mathrm{C}$ | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Propagation Delay Skew ${ }^{5}$ | tpsk |  |  | 15 | ns | $\mathrm{C}_{L}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Channel-to-Channel Matching, Codirectional Channels ${ }^{6}$ | tPSKCD |  |  | 3 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}$, CMOS signal levels |
| Channel-to-Channel Matching, Opposing Directional Channels ${ }^{6}$ | tPSKOD |  |  | 15 | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| Output Rise/Fall Time (10\% to 90\%) | $\mathrm{t}_{\mathrm{R}} / \mathrm{t}_{\mathrm{f}}$ |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 3.0 |  | ns | $\mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 2.5 |  | ns | $\mathrm{C}_{L}=15 \mathrm{pF}, \mathrm{CMOS}$ signal levels |
| For All Models |  |  |  |  |  |  |
| Common-Mode Transient Immunity at Logic High Output ${ }^{7}$ | \|CM ${ }_{\text {H }}$ | 25 | 35 |  | $\mathrm{kV} / \mu \mathrm{s}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{Ix}}=\mathrm{V}_{\mathrm{DD} 1}, \mathrm{~V}_{\mathrm{DD} 2}, \mathrm{~V}_{\mathrm{CM}}=1000 \mathrm{~V}, \\ & \text { transient magnitude }=800 \mathrm{~V} \end{aligned}$ |
| Common-Mode Transient Immunity at Logic Low Output ${ }^{7}$ | \| $\mathrm{CM}_{\mathrm{L}}{ }^{\text {\| }}$ | 25 | 35 |  | $\mathrm{kV} / \mu \mathrm{s}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{Ix}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{CM}}=1000 \mathrm{~V}, \\ & \text { transient magnitude }=800 \mathrm{~V} \end{aligned}$ |
| Refresh Rate | $\mathrm{fr}_{\mathrm{r}}$ |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 1.2 |  | Mbps |  |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 1.1 |  | Mbps |  |
| Input Dynamic Supply Current, per Channel ${ }^{8}$ | $\operatorname{ldDI}(\mathrm{D})$ |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 0.19 |  | mA/Mbps |  |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 0.10 |  | mA/Mbps |  |
| Output Dynamic Supply Current, per Channel ${ }^{8}$ | IDDO (D) |  |  |  |  |  |
| $5 \mathrm{~V} / 3 \mathrm{~V}$ Operation |  |  | 0.03 |  | mA/Mbps |  |
| $3 \mathrm{~V} / 5 \mathrm{~V}$ Operation |  |  | 0.05 |  | mA/Mbps |  |

${ }^{1}$ The supply current values for both channels are combined when running at identical data rates. Output supply current values are specified with no output load present. The supply current associated with an individual channel operating at a given data rate may be calculated as described in the Power Consumption section. See Figure 6 through Figure 8 for information on per-channel supply current as a function of data rate for unloaded and loaded conditions. See Figure 9 through Figure 11 for total $I_{D D 1}$ and $\mathrm{I}_{D 2}$ supply currents as a function of data rate for ADuM3200 and ADuM3201 channel configurations.
${ }^{2}$ The minimum pulse width is the shortest pulse width at which the specified pulse-width distortion is guaranteed.
${ }^{3}$ The maximum data rate is the fastest data rate at which the specified pulse-width distortion is guaranteed.
${ }^{4} t_{\text {PHL }}$ propagation delay is measured from the $50 \%$ level of the falling edge of the $V_{\text {Ix }}$ signal to the $50 \%$ level of the falling edge of the $V_{\text {Ox }}$ signal. $t_{\text {PLH }}$ propagation delay is measured from the $50 \%$ level of the rising edge of the $V_{1 x}$ signal to the $50 \%$ level of the rising edge of the $V_{0 x}$ signal.
${ }^{5} t_{\text {PSK }}$ is the magnitude of the worst-case difference in $t_{\text {PHL }}$ and/or $t_{\text {PLH }}$ that is measured between units at the same operating temperature, supply voltages, and output load within the recommended operating conditions.
${ }^{6}$ Codirectional channel-to-channel matching is the absolute value of the difference in propagation delays between any two channels with inputs on the same side of the isolation barrier. Opposing directional channel-to-channel matching is the absolute value of the difference in propagation delays between any two channels with inputs on opposing sides of the isolation barrier.
${ }^{7} \mathrm{CM}_{H}$ is the maximum common-mode voltage slew rate that can be sustained while maintaining $\mathrm{V}_{\mathrm{O}}>0.8 \mathrm{~V}_{\mathrm{DD} 2}$. $\mathrm{CM} M_{\mathrm{L}}$ is the maximum common-mode voltage slew rate that can be sustained while maintaining $\mathrm{V}_{0}<0.8 \mathrm{~V}$. The common-mode voltage slew rates apply to both rising and falling common-mode voltage edges. The transient magnitude is the range over which the common mode is slewed.
${ }^{8}$ Dynamic supply current is the incremental amount of supply current required for a 1 Mbps increase in the signal data rate. See Figure 6 through Figure 8 for information on per-channel supply current for unloaded and loaded conditions. See the Power Consumption section for guidance on calculating per-channel supply current for a given data rate.

## ADuM3200/ADuM3201

## PACKAGE CHARACTERISTICS

Table 4.

| Parameter | Symbol | Min | Typ | Max | Unit | Test Conditions |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Resistance (Input to Output) ${ }^{1}$ | R.o |  | $10^{12}$ |  | $\Omega$ |  |
| Capacitance (Input to Output) ${ }^{1}$ | C10 |  | 1.0 |  | pF | $\mathrm{f}=1 \mathrm{MHz}$ |
| Input Capacitance | $\mathrm{Cl}_{1}$ |  | 4.0 |  | pF |  |
| IC Junction-to-Case Thermal Resistance, Side 1 | $\theta_{\text {Jcı }}$ |  | 46 |  | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ | Thermocouple located at center of package underside |
| IC Junction-to-Case Thermal Resistance, Side 2 | $\theta_{\text {лсо }}$ |  | 41 |  | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |  |

${ }^{1}$ The device is considered a 2-terminal device; Pin 1, Pin 2, Pin 3, and Pin 4 are shorted together, and Pin 5, Pin 6, Pin 7, and Pin 8 are shorted together.

## REGULATORY INFORMATION

The ADuM3200/ADuM3201 is approved by the following organizations.
Table 5.

| UL | CSA | VDE |
| :--- | :--- | :--- |
| Recognized under 1577 Component | Approved under CSA Component | Certified according to DIN EN 60747-5-2 (VDE 0884 Part 2): |
| Recognition Program $^{1}$ | Acceptance Notice \#5A | $2003-01^{2}$ |
| 2500 V rms isolation voltage |  | Basic insulation, 560 V peak |
| File E214100 | File 205078 | File 2471900-4880-0001 |

${ }^{1}$ In accordance with UL1577, each ADuM320x is proof-tested by applying an insulation test voltage $\geq 3000 \mathrm{Vrms}$ for 1 second (current leakage detection limit $=5 \mu \mathrm{~A}$ ).
${ }^{2}$ In accordance with DIN EN 60747-5-2, each ADuM320x is proof-tested by applying an insulation test voltage $\geq 1050 \mathrm{~V}$ peak for 1 second (partial discharge detection limit $=5 \mathrm{pC}$ ).

## INSULATION AND SAFETY-RELATED SPECIFICATIONS

Table 6.

| Parameter | Symbol | Value | Unit | Conditions |
| :---: | :---: | :---: | :---: | :---: |
| Rated Dielectric Insulation Voltage |  | 2500 | V rms | 1-minute duration |
| Minimum External Air Gap (Clearance) | L(I01) | 4.90 min | mm | Measured from input terminals to output terminals, shortest distance through air |
| Minimum External Tracking (Creepage) | L(I02) | 4.01 min | mm | Measured from input terminals to output terminals, shortest distance path along body |
| Minimum Internal Gap (Internal Clearance) |  | 0.017 min | mm | Insulation distance through insulation |
| Tracking Resistance (Comparative Tracking Index) | CTI | >175 | V | DIN IEC 112/VDE 0303 Part 1 |
| Isolation Group |  | Illa |  | Material Group (DIN VDE 0110, 1/89, Table 1) |

DIN EN 60747-5-2 (VDE 0884 PART 2) INSULATION CHARACTERISTICS

Table 7.

| Description | Symbol | Characteristic | Unit |
| :---: | :---: | :---: | :---: |
| Installation Classification Per DIN VDE 0110 |  |  |  |
| For Rated Mains Voltage $\leq 150 \mathrm{~V}$ rms |  | I-IV |  |
| For Rated Mains Voltage $\leq 300 \mathrm{~V}$ rms |  | I-III |  |
| For Rated Mains Voltage $\leq 400 \mathrm{~V}$ rms |  | 1-II |  |
| Climatic Classification |  | 40/105/21 |  |
| Pollution Degree (DIN VDE 0110, Table 1) |  | 2 |  |
| Maximum Working Insulation Voltage | VIorm | 560 | $\checkmark$ peak |
| Input-to-Output Test Voltage, Method b1 | $V_{\text {PR }}$ | 1050 | $\checkmark$ peak |
| $V_{\text {IORM }} \times 1.875=\mathrm{V}_{\text {Pr, }}, 100 \%$ Production Test, $\mathrm{t}_{\mathrm{m}}=1 \mathrm{sec}$, Partial Discharge $<5 \mathrm{pC}$ |  |  |  |
| Input-to-Output Test Voltage, Method a | $V_{\text {PR }}$ |  |  |
| After Environmental Tests Subgroup 1 |  |  |  |
| $\mathrm{V}_{\text {IORM }} \times 1.6=\mathrm{V}_{\text {PR, }} \mathrm{t}_{\mathrm{m}}=60 \mathrm{sec}$, Partial Discharge $<5 \mathrm{pC}$ |  | 896 | $V$ peak |
| After Input and/or Safety Test Subgroup 2/3 |  |  |  |
| $\mathrm{V}_{\text {IORM }} \times 1.2=\mathrm{V}_{\text {PR, }}, \mathrm{t}_{\mathrm{m}}=60 \mathrm{sec}$, Partial Discharge $<5 \mathrm{pC}$ |  | 672 | $\checkmark$ peak |
| Highest Allowable Overvoltage (Transient Overvoltage, $\mathrm{t}_{\text {TR }}=10 \mathrm{sec}$ ) | $V_{\text {TR }}$ | 4000 | $\checkmark$ peak |
| Safety-Limiting Values (Maximum Value Allowed in the Event of a Failure; also See Figure 3) |  |  |  |
| Case Temperature | Ts | 150 | ${ }^{\circ} \mathrm{C}$ |
| Side 1 Current | $\mathrm{I}_{51}$ | 160 | mA |
| Side 2 Current | Is2 | 170 | mA |
| Insulation Resistance at $\mathrm{T}_{5}, \mathrm{~V}_{10}=500 \mathrm{~V}$ | Rs | $>10^{9}$ | $\Omega$ |

Note that the "*" marking on the package denotes DIN EN 60747-5-2 approval for a 560 V peak working voltage.
This isolator is suitable for basic isolation only within the safety limit data. Maintenance of the safety data is ensured by protective circuits.


Figure 3. Thermal Derating Curve, Dependence of SafetyLimiting Values on Case Temperature, per DIN EN 60747-5-2

RECOMMENDED OPERATING CONDITIONS

Table 8.

| Parameter | Symbol | Min | Max | Unit |
| :--- | :--- | :--- | :--- | :--- |
| Operating Temperature | $\mathrm{T}_{\mathrm{A}}$ | -40 | +105 | ${ }^{\circ} \mathrm{C}$ |
| Supply Voltages $^{1}$ | $\mathrm{~V}_{\mathrm{DD} 1}, \mathrm{~V}_{\mathrm{DD} 2}$ | 2.7 | 5.5 | V |
| Input Signal Rise and Fall Times |  |  | 1.0 | ms |

${ }^{1}$ All voltages are relative to their respective ground. See the DC Correctness and Magnetic Field Immunity section for information on immunity to external magnetic fields.

## ADuM3200/ADuM3201

## ABSOLUTE MAXIMUM RATINGS

Ambient temperature $=25^{\circ} \mathrm{C}$, unless otherwise noted.
Table 9.

| Parameter | Symbol | Min | Max | Unit |
| :---: | :---: | :---: | :---: | :---: |
| Storage Temperature | $\mathrm{T}_{\text {ST }}$ | -55 | +150 | ${ }^{\circ} \mathrm{C}$ |
| Ambient Operating Temperature | $\mathrm{T}_{\text {A }}$ | -40 | +105 | ${ }^{\circ} \mathrm{C}$ |
| Supply Voltages ${ }^{1}$ | $V_{D D 1}, V_{\text {DD2 }}$ | -0.5 | +7.0 | V |
| Input Voltage ${ }^{1,2}$ | $\mathrm{V}_{\text {IA }}, \mathrm{V}_{\text {IB }}$ | -0.5 | $V_{\text {DDI }}+0.5$ | V |
| Output Voltage ${ }^{1,2}$ | $V_{\text {OA, }} \mathrm{V}_{\text {OB }}$ | -0.5 | $V_{\text {DDO }}+0.5$ | V |
| Average Output Current, per Pin ${ }^{3}$ | lo | -35 | +35 | mA |
| Common-Mode Transients ${ }^{4}$ | CM ${ }_{\text {H, }} \mathrm{CM}_{\mathrm{L}}$ | -100 | +100 | $\mathrm{kV} / \mu \mathrm{s}$ |

${ }^{1}$ All voltages are relative to their respective ground.
${ }^{2} V_{D D I}$ and $V_{D D O}$ refer to the supply voltages on the input and output sides of a given channel, respectively.
${ }^{3}$ See Figure 3 for maximum rated current values for various temperatures.
${ }^{4}$ Refers to common-mode transients across the insulation barrier. Common-mode transients exceeding the Absolute Maximum Rating can cause latch-up or permanent damage.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; Functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.

Table 10. ADuM3200 Truth Table (Positive Logic)

| $\mathrm{V}_{\text {IA }}$ Input | Vis Input | VDD1 State | VDD2 State | VoA Output | Vob Output | Notes |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| H | H | Powered | Powered | H | H |  |
| L | L | Powered | Powered | L | L |  |
| H | L | Powered | Powered | H | L |  |
| L | H | Powered | Powered | L | H |  |
| X | X | Unpowered | Powered | H | H | Outputs return to the input state within $1 \mu \mathrm{~s}$ of $\mathrm{V}_{\text {DII }}$ power restoration. |
| x | x | Powered | Unpowered | Indeterminate | Indeterminate | Outputs return to the input state within $1 \mu \mathrm{~s}$ of $\mathrm{V}_{\mathrm{DDO}}$ power restoration. |

Table 11. ADuM3201 Truth Table (Positive Logic)

| $\mathrm{V}_{\text {IA }}$ Input | $\mathrm{V}_{\text {IB }}$ Input | VDD1 State | $\mathrm{V}_{\mathrm{DD} 2}$ State | V ${ }_{\text {A }}$ Output | VoB Output | Notes |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| H | H | Powered | Powered | H | H |  |
| L | L | Powered | Powered | L | L |  |
| H | L | Powered | Powered | H | L |  |
| L | H | Powered | Powered | L | H |  |
| x | X | Unpowered | Powered | Indeterminate | H | Outputs return to the input state within $1 \mu \mathrm{~s}$ of $\mathrm{V}_{\mathrm{DII}}$ power restoration. |
| X | X | Powered | Unpowered | H | Indeterminate | Outputs return to the input state within $1 \mu \mathrm{~s}$ of $\mathrm{V}_{\text {DDO }}$ power restoration. |

## PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS



Figure 4. ADuM3200 Pin Configuration


Figure 5. ADuM3201 Pin Configuration

Table 12. ADuM3200 Pin Function Descriptions

| Pin <br> No. | Mnemonic | Function |
| :--- | :--- | :--- |
| 1 | $\mathrm{~V}_{\mathrm{DD} 1}$ | Supply Voltage for Isolator Side 1, 2.7 V to 5.5 V. |
| 2 | $\mathrm{~V}_{\mathrm{IA}}$ | Logic Input A. |
| 3 | $\mathrm{~V}_{\mathrm{IB}}$ | Logic Input B. |
| 4 | $\mathrm{GND}_{1}$ | Ground 1. Ground reference for Isolator Side 1. |
| 5 | $\mathrm{GND}_{2}$ | Ground 2. Ground reference for Isolator Side 2. |
| 6 | $\mathrm{~V}_{\mathrm{OB}}$ | Logic Output B. |
| 7 | $\mathrm{~V}_{\mathrm{OA}}$ | Logic Output A. |
| 8 | $\mathrm{~V}_{\mathrm{DD} 2}$ | Supply Voltage for Isolator Side 2, 2.7 V to 5.5 V. |

Table 13. ADuM3201 Pin Function Descriptions

| Pin <br> No. | Mnemonic | Function |
| :--- | :--- | :--- |
| 1 | $\mathrm{~V}_{\mathrm{DD} 1}$ | Supply Voltage for Isolator Side 1, 2.7 V to 5.5 V. |
| 2 | $\mathrm{~V}_{\mathrm{OA}}$ | Logic Output A. |
| 3 | $\mathrm{~V}_{I B}$ | Logic Input B. |
| 4 | $\mathrm{GND}_{1}$ | Ground 1. Ground reference for Isolator Side 1. |
| 5 | $\mathrm{GND}_{2}$ | Ground 2. Ground reference for Isolator Side 2. |
| 6 | $\mathrm{~V}_{\mathrm{OB}}$ | Logic Output B. |
| 7 | $\mathrm{~V}_{I A}$ | Logic Input A. |
| 8 | $\mathrm{~V}_{\mathrm{DD} 2}$ | Supply Voltage for Isolator Side 2, 2.7 V to 5.5 V. |

## ADuM3200/ADuM3201

## TYPICAL PERFORMANCE CHARACTERISTICS



Figure 6. Typical Input Supply Current per Channel vs. Data Rate for 5 V and 3 V Operation


Figure 7. Typical Output Supply Current per Channel vs. Data Rate for 5 V and 3 V Operation (No Output Load)


Figure 8. Typical Output Supply Current per Channel vs. Data Rate for 5 V and 3 V Operation (15 pF Output Load)


Figure 9. Typical ADuM3200 VDD1 Supply Current vs. Data Rate for 5 V and 3 V Operation


Figure 10. Typical ADuM3200 VDD2 Supply Current vs. Data Rate for 5 V and 3 V Operation


Figure 11. Typical ADuM3201 VDD1 or VDD2 Supply Current vs. Data Rate for 5 V and 3 V Operation

## APPLICATION INFORMATION

## PC BOARD LAYOUT

The ADuM320x digital isolators require no external interface circuitry for the logic interfaces. Power supply bypassing is strongly recommended at the input and output supply pins. The capacitor value should be between $0.01 \mu \mathrm{~F}$ and $0.1 \mu \mathrm{~F}$. The total lead length between both ends of the capacitor and the input power supply pin should not exceed 20 mm .

## SYSTEM-LEVEL ESD CONSIDERATIONS AND ENHANCEMENTS

System-level ESD reliability (for example, per IEC 61000-4-x) is highly dependent on system design which varies widely by application. The ADuM320x incorporate many enhancements to make ESD reliability less dependent on system design. The enhancements include:

- ESD protection cells added to all input/output interfaces.
- Key metal trace resistances reduced using wider geometry and paralleling of lines with vias.
- The SCR effect inherent in CMOS devices minimized by use of guarding and isolation technique between PMOS and NMOS devices.
- Areas of high electric field concentration eliminated using $45^{\circ}$ corners on metal traces.
- Supply pin overvoltage prevented with larger ESD clamps between each supply pin and its respective ground.

While the ADuM320x improve system-level ESD reliability, they are no substitute for a robust system-level design. See Application Note AN-793, ESD/Latch-Up Considerations with iCoupler Isolation Products for detailed recommendations on board layout and system-level design.

## PROPAGATION DELAY-RELATED PARAMETERS

Propagation delay is a parameter that describes the time it takes a logic signal to propagate through a component. The propagation delay to a logic low output can differ from the propagation delay to a logic high.


Figure 12. Propagation Delay Parameters
Pulse-width distortion is the maximum difference between these two propagation delay values and is an indication of how accurately the input signal's timing is preserved.

Channel-to-channel matching refers to the maximum amount that the propagation delay differs between channels within a single ADuM320x component.

Propagation delay skew refers to the maximum amount that the propagation delay differs between multiple ADuM320x components operating under the same conditions.

## DC CORRECTNESS AND MAGNETIC FIELD IMMUNITY

Positive and negative logic transitions at the isolator input cause narrow ( $\sim 1 \mathrm{~ns}$ ) pulses to be sent to the decoder via the transformer. The decoder is bistable and is therefore either set or reset by the pulses, indicating input logic transitions. In the absence of logic transitions of more than $2 \mu \mathrm{~s}$ at the input, a periodic set of refresh pulses indicative of the correct input state are sent to ensure dc correctness at the output. If the decoder receives no internal pulses for more than about $5 \mu \mathrm{~s}$, the input side is assumed to be unpowered or nonfunctional, in which case, the isolator output is forced to a default state (see Table 8) by the watchdog timer circuit.

The ADuM320x are extremely immune to external magnetic fields. The limitation on the ADuM320x's magnetic field immunity is set by the condition in which induced voltage in the transformer's receiving coil is sufficiently large to either falsely set or reset the decoder. The following analysis defines the conditions under which this can occur. The 3 V operating condition of the ADuM320x is examined because it represents the most susceptible mode of operation.

The pulses at the transformer output have an amplitude greater than 1.0 V . The decoder has a sensing threshold at about 0.5 V , therefore establishing a 0.5 V margin in which induced voltages can be tolerated. The voltage induced across the receiving coil is given by

$$
V=(-\mathrm{d} \beta / d t) \sum \pi r_{n}^{2}, n=1,2, \ldots, N
$$

where:
$\beta$ is the magnetic flux density (gauss).
$N$ is the number of turns in the receiving coil.
$r_{n}$ is the radius of the nth turn in the receiving coil ( cm ).
Given the geometry of the receiving coil in the ADuM320x and an imposed requirement that the induced voltage be at most $50 \%$ of the 0.5 V margin at the decoder, a maximum allowable magnetic field is calculated, as shown in Figure 13.


Figure 13. Maximum Allowable External Magnetic Flux Density
For example, at a magnetic field frequency of 1 MHz , the maximum allowable magnetic field of 0.2 kgauss induces a voltage of 0.25 V at the receiving coil. This is about $50 \%$ of the sensing threshold and does not cause a faulty output transition. Similarly, if such an event were to occur during a transmitted pulse (and had the worst-case polarity), it would reduce the received pulse from $>1.0 \mathrm{~V}$ to 0.75 V -still well above the 0.5 V sensing threshold of the decoder.

The preceding magnetic flux density values correspond to specific current magnitudes at given distances away from the ADuM320x transformers. Figure 14 expresses these allowable current magnitudes as a function of frequency for selected distances. As seen, the ADuM320x are extremely immune and can be affected only by extremely large currents operated at high frequency and very close to the component. For the 1 MHz example, one would have to place a 0.5 kA current 5 mm away from the ADuM320x to affect the component's operation.


Figure 14. Maximum Allowable Current for Various Current-to-ADuM320x Spacings

Note that at combinations of strong magnetic fields and high frequencies, any loops formed by printed circuit board traces could induce sufficiently large error voltages to trigger the threshold of succeeding circuitry. Care should be taken in the layout of such traces to avoid this possibility.

## POWER CONSUMPTION

The supply current at a given channel of the ADuM320x isolator is a function of the supply voltage, the channel's data rate, and the channel's output load.

For each input channel, the supply current is given by

$$
\begin{array}{ll}
I_{D D I}=I_{D D I(Q)} & f \leq 0.5 f_{r} \\
I_{D D I}=I_{D D I(D)} \times\left(2 f-f_{r}\right)+I_{D D I(Q)} & \mathrm{f}>0.5 f_{r}
\end{array}
$$

for each output channel, the supply current is given by

$$
\begin{array}{rr}
I_{D D O}=I_{D D O(Q)} & f \leq 0.5 f_{r} \\
I_{D D O}=\left(I_{D D O}(D)+\left(0.5 \times 10^{-3}\right) \times C_{L} V_{D D O}\right) \times\left(2 f-f_{r}\right)+I_{D D O(Q)} \\
f>0.5 f_{r}
\end{array}
$$

where:
$I_{D D I(D)}, I_{D D O(D)}$ are the input and output dynamic supply currents per channel (mA/Mbps).
$C_{L}$ is the output load capacitance ( pF ).
$V_{D D o}$ is the output supply voltage (V).
$f$ is the input logic signal frequency ( MHz , half of the input data rate, NRZ signaling).
$f_{r}$ is the input stage refresh rate (Mbps).
$I_{D D I(Q)}, I_{D D O}(Q)$ are the specified input and output quiescent supply currents (mA).

To calculate the total $\mathrm{I}_{\mathrm{DD} 1}$ and $\mathrm{I}_{\mathrm{DD} 2}$ supply current, the supply currents for each input and output channel corresponding to $\mathrm{I}_{\mathrm{DD} 1}$ and $\mathrm{I}_{\mathrm{DD} 2}$ are calculated and totaled. Figure 6 provides perchannel input supply currents as a function of data rate. Figure 7 and Figure 8 provide per-channel output supply currents as a function of data rate for an unloaded output condition and for a 15 pF output condition, respectively. Figure 9 through Figure 11 provide total $I_{D D 1}$ and $I_{D D 2}$ supply current as a function of data rate for ADuM3200 and ADuM3201 channel configurations.

## ADuM3200/ADuM3201

## OUTLINE DIMENSIONS



CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS (IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

Figure 15. 8-Lead Standard Small Outline Package [SOIC_N] Narrow Body (R-8)
Dimensions shown in millimeters (inches)

## ORDERING GUIDE

| Model | Number of Inputs, $V_{\text {DD } 1}$ Side | Number of Inputs, $V_{D D 2}$ Side | Maximum Data Rate (Mbps) | Maximum Propagation Delay, 5 V (ns) | Maximum <br> Pulse-Width Distortion (ns) | Temperature Range ( ${ }^{\circ} \mathrm{C}$ ) | Package Option ${ }^{1}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ADuM3200ARZ ${ }^{2}$ | 2 | 0 | 1 | 150 | 40 | -40 to +105 | R-8 |
| ADuM3200ARZ-RL7 ${ }^{2}$ | 2 | 0 | 1 | 150 | 40 | -40 to +105 | R-8 |
| ADuM3200BRZ ${ }^{2}$ | 2 | 0 | 10 | 50 | 3 | -40 to +105 | R-8 |
| ADuM3200BRZ-RL7² | 2 | 0 | 10 | 50 | 3 | -40 to +105 | R-8 |
| ADuM3200CRZ ${ }^{2}$ | 2 | 0 | 25 | 45 | 3 | -40 to +105 | R-8 |
| ADuM3200CRZ-RL7 ${ }^{2}$ | 2 | 0 | 25 | 45 | 3 | -40 to +105 | R-8 |
| ADuM3201ARZ ${ }^{2}$ | 1 | 1 | 1 | 150 | 40 | -40 to +105 | R-8 |
| ADuM3201ARZ-RL7² | 1 | 1 | 1 | 150 | 40 | -40 to +105 | R-8 |
| ADuM3201BRZ ${ }^{2}$ | 1 | 1 | 10 | 50 | 3 | -40 to +105 | R-8 |
| ADuM3201BRZ-RL7 ${ }^{2}$ | 1 | 1 | 10 | 50 | 3 | -40 to +105 | R-8 |
| ADuM3201CRZ ${ }^{2}$ | 1 | 1 | 25 | 45 | 3 | -40 to +105 | R-8 |
| ADuM3201CRZ-RL7² | 1 | 1 | 25 | 45 | 3 | -40 to +105 | R-8 |

[^0]ADuM3200/ADuM3201

## NOTES

## NOTES

## ADuM3200/ADuM3201

## NOTES


[^0]:    ${ }^{1}$ R-8 = 8-lead narrow body SOIC_N.
    ${ }^{2} Z=P b$-free part.

